

Search Notes



Application/Control No.

10/757,974

Examiner

Hiep Nguyen

Applicant(s)/Patent under Reexamination

TIHANYI, JENOE

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	380	02.07.05	HN
	383	↓	↓
	384	↓	↓
	427	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST See attachment	02.07.05	HN
Consulted with Tuan Lam	02.07.05	HN